


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578133	<b>Applicant(s)/Patent Under Reexamination</b>  SHIN ET AL.
	<b>Examiner</b>  Leigh C Maier	<b>Art Unit</b>  1623

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SEARCH NOTES		
Search Notes	Date	Examiner
EAST	1/26/09	LCM

INTERFERENCE SEARCH			
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